

C1808C439CHGACTU

Aliases (C1808C439CHGAC7800)

SMD Comm COG HV, Ceramic, 4.3 pF, +/-0.25 pF, 3,000 VDC, COG, SMD, MLCC, Ultra-Stable, Low Loss, Class I, 1808, 2.9 mm



Click [here](#) for the 3D model.

General Information

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| Series | SMD Comm COG HV |
| Style | SMD Chip |
| Description | SMD, MLCC, Ultra-Stable, Low Loss, Class I |
| Features | Ultra-Stable, Low Loss, Class I |
| RoHS | Yes |
| Termination | Tin |
| Marking | No |
| AEC-Q200 | No |
| Typical Component Weight | 81 mg |
| Shelf Life | 78 Weeks |
| MSL | 1 |

Dimensions

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|-----------|-----------------|
| Chip Size | 1808 |
| L | 4.7mm +/-0.5mm |
| W | 2mm +/-0.2mm |
| T | 1.6mm +/-0.15mm |
| S | 2.9mm MIN |
| B | 0.6mm +/-0.35mm |

Packaging Specifications

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|--------------------|--------------------------|
| Packaging | T&R, 180mm, Plastic Tape |
| Packaging Quantity | 1000 |

Specifications

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|--|------------------------|
| Capacitance | 4.3 pF |
| Measurement Condition | 1 MHz 1.0Vrms |
| Tolerance | +/-0.25 pF |
| Voltage DC | 3000 VDC |
| Dielectric Withstanding Voltage | 3,600 VDC |
| Temperature Range | -55/+125°C |
| Temp. Coefficient | COG |
| Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC) | 30 ppm/C, 1MHz 1.0Vrms |
| Dissipation Factor | 0.1% 1 MHz 1.0Vrms |
| Aging Rate | 0% Loss/Decade Hour |
| Insulation Resistance | 100 GOhms |

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